IRFR5305PbF

IRFU5305PbF

## International Rectifier

- Ultra Low On-Resistance
- Surface Mount (IRFR5305)
- Straight Lead (IRFU5305)
- Advanced Process Technology
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

# G

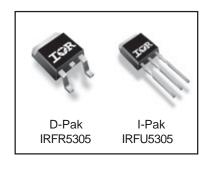
# $V_{DSS} = -55V$ $R_{DS(on)} = 0.065\Omega$ $I_{D} = -31A$

HEXFET® Power MOSFET

#### **Description**

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET® Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D-Pak is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



#### **Absolute Maximum Ratings**

	•		
	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-31	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-22	A
I <sub>DM</sub>	Pulsed Drain Current ① ⑥	-110	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	110	W
	Linear Derating Factor	0.71	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy@6	280	mJ
I <sub>AR</sub>	Avalanche Current ① ⑥	-16	A
E <sub>AR</sub>	Repetitive Avalanche Energy①	11	mJ
dv/dt	Peak Diode Recovery dv/dt 3 6	-5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		∞
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 srew	10 lbf•in (1.1N•m)	

#### Thermal Resistance

	Parameter	Тур.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case		1.4	
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)*		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient**		110	

#### IRFR/U5305PbF

#### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_D = -250 \mu A$	
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient		-0.034		V/°C	Reference to 25°C, I <sub>D</sub> = -1mA	
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.065	Ω	V <sub>GS</sub> = -10V, I <sub>D</sub> = -16A ④	
V <sub>GS(th)</sub>	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
9 <sub>fs</sub>	Forward Transconductance	8.0			S	V <sub>DS</sub> = -25V, I <sub>D</sub> = -16A©	
lana	Drain-to-Source Leakage Current			-25	μA	$V_{DS} = -55V, V_{GS} = 0V$	
I <sub>DSS</sub>	Brain-to-Gourde Leakage Gurrent			-250	μΑ	$V_{DS} = -44V$ , $V_{GS} = 0V$ , $T_{J} = 150$ °C	
Lana	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V	
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	IIA	V <sub>GS</sub> = -20V	
Qg	Total Gate Charge			63		I <sub>D</sub> = -16A	
Q <sub>gs</sub>	Gate-to-Source Charge			13	nC	$V_{DS} = -44V$	
$Q_{gd}$	Gate-to-Drain ("Miller") Charge			29		V <sub>GS</sub> = -10V, See Fig. 6 and 13 ⊕ ®	
t <sub>d(on)</sub>	Turn-On Delay Time		14			$V_{DD} = -28V$	
t <sub>r</sub>	Rise Time		66			$I_{D} = -16A$	
t <sub>d(off)</sub>	Turn-Off Delay Time		39		ns	$R_G = 6.8\Omega$	
t <sub>f</sub>	Fall Time		63			$R_D = 1.6\Omega$ , See Fig. 10 $\oplus$ $\otimes$	
	Internal Drain Industrian		4.5			Between lead,	
L <sub>D</sub>	Internal Drain Inductance		4.5		nH	6mm (0.25in.)	
L <sub>S</sub>	Internal Source Inductance		7.5		ПП	from package	
						and center of die contact S	
C <sub>iss</sub>	Input Capacitance		1200	_		$V_{GS} = 0V$	
C <sub>oss</sub>	Output Capacitance		520		рF	$V_{DS} = -25V$	
C <sub>rss</sub>	Reverse Transfer Capacitance		250			f = 1.0MHz, See Fig. 5 ®	

#### Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current			21		MOSFET symbol	
	(Body Diode)			-31	A	showing the	
I <sub>SM</sub>	Pulsed Source Current			440	1 ^	integral reverse c	
	(Body Diode) ①	-110		p-n junction diode.			
V <sub>SD</sub>	Diode Forward Voltage			-1.3	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = -16A, V <sub>GS</sub> = 0V ④	
t <sub>rr</sub>	Reverse Recovery Time		71	110	ns	$T_J = 25$ °C, $I_F = -16A$	
Q <sub>rr</sub>	Reverse Recovery Charge		170	250	nC	di/dt = -100A/µs ④ ⑥	

#### Notes

- ① Repetitive rating; pulse width limited by max. junction temperature. (See Fig. 11)
- ②  $V_{DD}$  = -25V, starting  $T_J$  = 25°C, L = 2.1mH  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = -16A. (See Figure 12)
- ③ I  $_{SD}$   $\leq$  -16A, di/dt  $\leq$  -280A/ $\mu$ s,  $V_{DD}$   $\leq$   $V_{(BR)DSS}$ ,  $T_{J}$   $\leq$  175°C
- 4 Pulse width  $\leq$  300 $\mu$ s; duty cycle  $\leq$  2%.
- © Uses IRF5305 data and test conditions.

For recommended footprint and soldering techniques refer to application note #AN-994.

<sup>\*</sup> When mounted on 1" square PCB (FR-4 or G-10 Material).

<sup>\*\*</sup> Uses typical socket mount.

### International TOR Rectifier

#### IRFR/U5305PbF

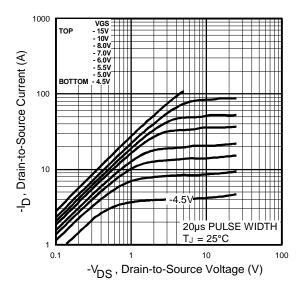


Fig 1. Typical Output Characteristics

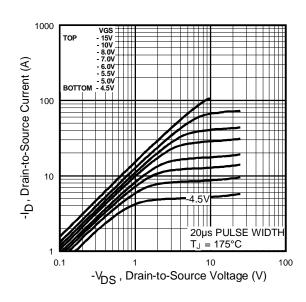


Fig 2. Typical Output Characteristics

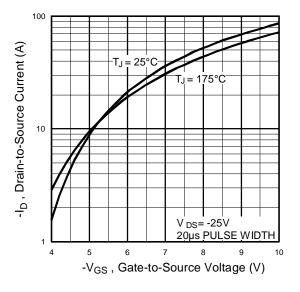
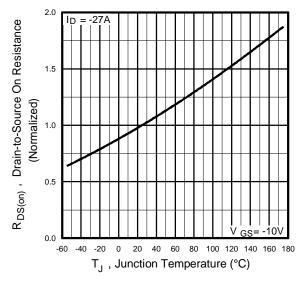
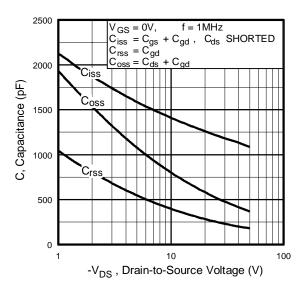


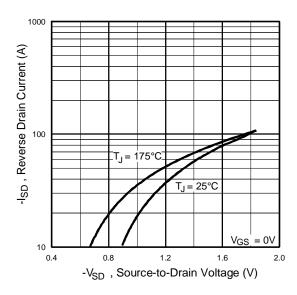
Fig 3. Typical Transfer Characteristics



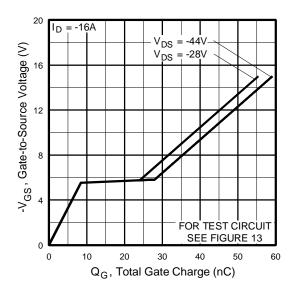
**Fig 4.** Normalized On-Resistance Vs. Temperature



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

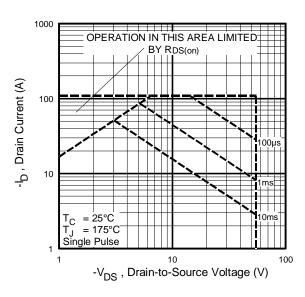


Fig 8. Maximum Safe Operating Area

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#### 35 30 (V) 25 20 20 25 50 75 100 125 150 175 T<sub>C</sub>, Case Temperature (°C)

**Fig 9.** Maximum Drain Current Vs. Case Temperature

#### IRFR/U5305PbF

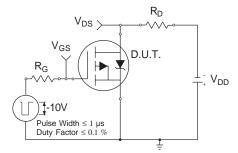


Fig 10a. Switching Time Test Circuit

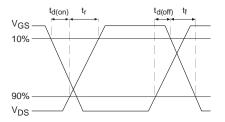


Fig 10b. Switching Time Waveforms

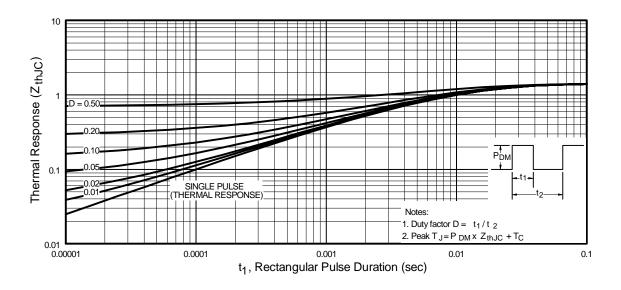


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

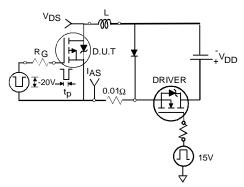


Fig 12a. Unclamped Inductive Test

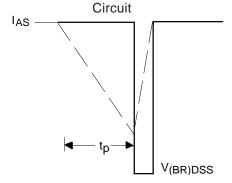


Fig 12b. Unclamped Inductive Waveforms

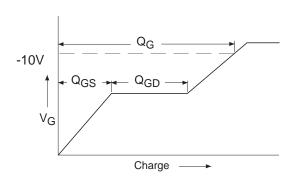
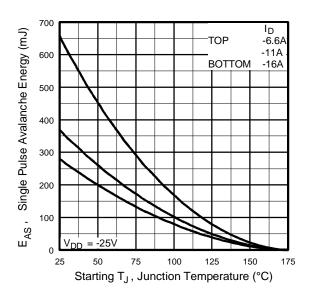


Fig 13a. Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

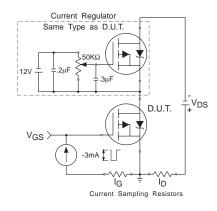
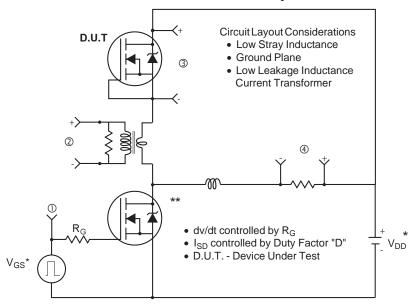


Fig 13b. Gate Charge Test Circuit

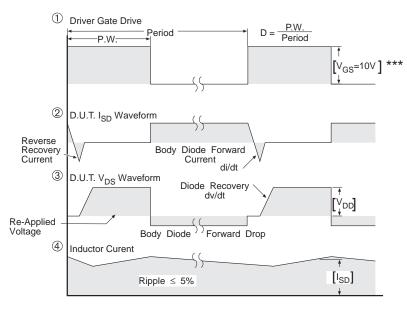
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#### Peak Diode Recovery dv/dt Test Circuit



<sup>\*</sup> Reverse Polarity for P-Channel

<sup>\*\*</sup> Use P-Channel Driver for P-Channel Measurements



<sup>\*\*\*</sup> V<sub>GS</sub> = 5.0V for Logic Level and 3V Drive Devices

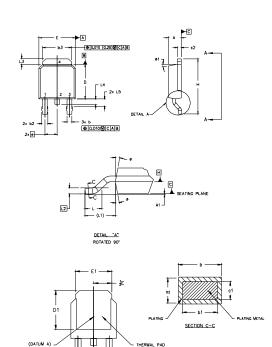
Fig 14. For P-Channel HEXFETS

#### IRFR/U5305PbF

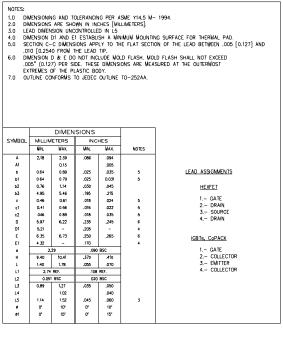


#### D-Pak (TO-252AA) Package Outline

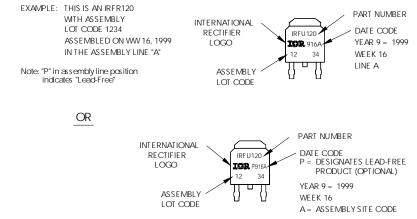
Dimensions are shown in millimeters (inches)



VIEW A-A



#### D-Pak (TO-252AA) Part Marking Information



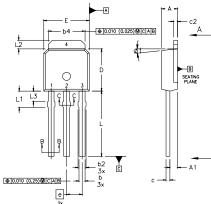
#### International IOR Rectifier

VIEW A-A

#### IRFR/U5305PbF

#### I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)



OIES:					
1	DIMENSIONING	ΔMD	TO EPANCING	DED	,

- ASME Y14,5 M- 1994,
- DMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
  DMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED
  0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST
  EXTREMES OF THE PLASTIC BODY.
- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.

  LEAD DIMENSION UNCONTROLLED IN L3,

INCHES

0.045

0.035 0,031

0.045

0.215

0.024

0.035

0.245

0.265

0,380

0.090

0.060

MIN. 0.086

0.035

0.025

0.030

0.030 0,195

0.018

0.018

0.235

0.250

0.170 0,350

0.075

0.045

NOTES

3, 4

- DIMENSION 61, 63 APPLY TO BASE METAL ONLY. OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA, CONTROLLING DIMENSION: INCHES.

DIMENSIONS

MILLIMETERS

MAX

MIN.

SYMBOL.

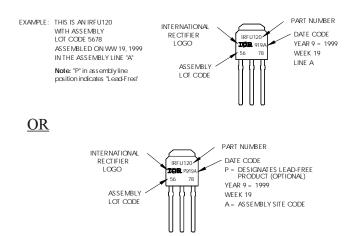
% -		A	2.18	2.39	ıl
0 (0.25) (0) C A B  3x	c —	A1	0,89	1,14	ı
e -		b	0,64	0.89	ı
2×		ь1	0,64	0.79	ı
		b2	0.76	1,14	ı
		b3	0.76	1,04	ı
^		b4	5.00	5.46	ı
<u> </u>		c	0.46	0.61	ı
+ E1+		c1	0.41	0,56	ı
		c2	.046	0,86	ı
<i>K</i>		D	5,97	6.22	ı
		D1	5.21	-	ı
T    D1 ⚠		E	6.35	6.73	ı
	<del>  (b, b2) </del>	E1	4.32	-	ı
└ <del>॒╶</del> ┟ <del>┈</del> ┦┼╀		e	2.	29	ıΓ
$\frac{1}{1}$ $\frac{1}{1}$ $\frac{1}{1}$		L	8,89	9.60	ıΓ
JIL JIL JIL	(c) c1	L1	1.91	2.29	ı
\ } \ } \ }		L2	0.89	1.27	ı
	+ 4///////	L3	1,14	1,52	ı
	Ы— b1, b3 —	ø1	O"	15*	ı
					ı
	SECTION A-A				ı
Ш Ш Ш	SECTION A-A				ı
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#### LEAD ASSIGNMENTS

#### HEXFET

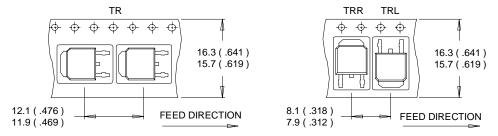
- 1,- GATE 2.- DRAIN
- 3,- SOURCE 4,- DRAIN

#### I-Pak (TO-251AA) Part Marking Information



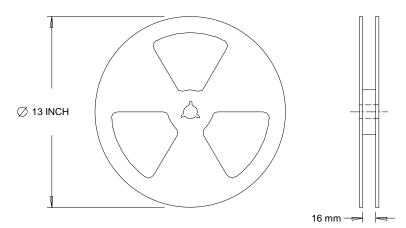
#### D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



#### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



#### NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Data and specifications subject to change without notice.



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